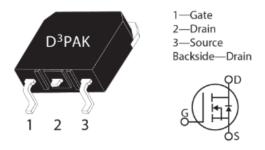


MSC017SMA120S Silicon Carbide N-Channel Power MOSFET

Product Overview

The silicon carbide (SiC) power MOSFET product line from Microsemi increases the performance over silicon MOSFET and silicon IGBT solutions while lowering the total cost of ownership for high-voltage applications. The MSC017SMA120S device is a 1200 V, 17 m Ω SiC MOSFET in a TO-268 (D3PAK) package.



Features

The following are key features of the MSC017SMA120S device:

- Low capacitances and low gate charge
- Fast switching speed due to low internal gate resistance (ESR)
- Stable operation at high junction temperature, T_{J(max)} = 175 °C
- · Fast and reliable body diode
- Superior avalanche ruggedness
- RoHS compliant

Benefits

The following are benefits of the MSC017SMA120S device:

- High efficiency to enable lighter, more compact system
- Simple to drive and easy to parallel
- Improved thermal capabilities and lower switching losses
- Eliminates the need for external freewheeling diode
- Lower system cost of ownership

Applications

The MSC017SMA120S device is designed for the following applications:

- PV inverter, converter, and industrial motor drives
- Smart grid transmission and distribution
- · Induction heating and welding
- H/EV powertrain and EV charger
- Power supply and distribution



Device Specifications

This section shows the specifications of the MSC017SMA120S device.

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the MSC017SMA120S device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
V _{DSS}	Drain source voltage	1200	V
I _D	Continuous drain current at T _C = 25 °C	100	А
	Continuous drain current at T _C = 100 °C	71	
I _{DM}	Pulsed drain current ¹	280	
V _{GS}	Gate-source voltage	23 to -10	V
P _D	Total power dissipation at T _C = 25 °C	357	w
	Linear derating factor	3.33	W/°C

Note:

1. Repetitive rating: pulse width and case temperature limited by maximum junction temperature.

The following table shows the thermal and mechanical characteristics of the MSC017SMA120S device.

Table 2 • Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit
R _{ÐJC}	Junction-to-case thermal resistance		0.28	0.42	°C/W
T _J	Operating junction temperature	-55		175	°C
T _{STG}	Storage temperature	-55		150	
TL	Soldering temperature for 10 seconds (1.6 mm from case)			300	
Wt	Package weight		0.14		OZ
			4.0		g



Electrical Performance

The following table shows the static characteristics of the MSC017SMA120S device. T_J = 25 °C unless otherwise specified.

Table 3 • Static Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V, } I_{D} = 100 \mu\text{A}$	1200			V
R _{DS(on)}	Drain-source on resistance ¹	V _{GS} = 20 V, I _D = 40 A		17.6	22	mΩ
V _{GS(th)}	Gate-source threshold voltage	$V_{GS} = V_{DS}, I_{D} = 4.5 \text{ mA}$	1.9	2.7		V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold voltage coefficient	$V_{GS} = V_{DS}$, $I_D = 4.5 \text{ mA}$		-4.6		mV/°C
I _{DSS}	Zero gate voltage drain current	V _{DS} , = 1200 V, V _{GS} = 0 V			100	μΑ
		V _{DS} = 1200 V, V _{GS} = 0 V T _J = 125 °C			500	-
I _{GSS}	Gate-source leakage current	V _{GS} = 20 V/–10 V			±100	nA

Note:

1. Pulse test: pulse width $< 380 \mu s$, duty cycle < 2%.

The following table shows the dynamic characteristics of the MSC017SMA120S device. $T_J = 25$ °C unless otherwise specified.

Table 4 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C _{iss}	Input capacitance	V _{GS} = 0 V, V _{DD} = 1000 V V _{AC} = 25 mV, f = 1 MHz		5280		pF
C _{rss}	Reverse transfer capacitance	VAC 25, 1		12		
C _{oss}	Output capacitance			265		
Q _g	Total gate charge	$V_{GS} = -5 \text{ V/20 V, } V_{DD} = 800 \text{ V}$ $I_D = 40 \text{ A}$		249		nC
Q_{gs}	Gate-source charge			63		
Q_{gd}	Gate-drain charge			32		
t _{d(on)}	Turn-on delay time	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V},$ $I_{D} = 50 \text{ A}, R_{g(ext)} = 4.0 \Omega,$		52		ns
t _f	Voltage fall time	Freewheeling diode = $MSC017SMA120S (V_{GS} = -5 V)$		21		
t _{d(off)}	Turn-off delay time			49		



Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
t _r	Voltage rise time			16		
E _{on}	Turn-on switching energy			1677		μ
E _{off}	Turn-off switching energy			395		
t _{d(on)}	Turn-on delay time	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V},$ $I_D = 50 \text{ A}, R_{g(ext)} = 4.0 \Omega$		49		ns
t _f	Voltage fall time	Freewheeling diode = MSC050SDA120B		19		
t _{d(off)}	Turn-off delay time			49		
t _r	Voltage rise time			14		
E _{on}	Turn-on switching energy			1329		μ
E _{off}	Turn-off switching energy			429		
ESR	Equivalent series resistance	f = 1 MHz, 25 mV, drain short		0.71		Ω
SCWT	Short circuit withstand time	V _{DS} = 960 V, V _{GS} = 20 V		3		μs
E _{AS}	Avalanche energy, single pulse	V _{DS} = 150 V, I _D = 30 A		3500		mJ

The following table shows the body diode characteristics of the MSC017SMA120S device. T_J = 25 °C unless otherwise specified.

Table 5 • Body Diode Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{SD}	Diode forward voltage	I _{SD} = 40 A, V _{GS} = 0 V		3.5		V
		$I_{SD} = 40 \text{ A}, V_{GS} = -5 \text{ V}$		3.9		V
t _{rr}	Reverse recovery time	$I_{SD} = 50 \text{ A}, V_{GS} = -5 \text{ V},$ Drive Rg = 4 Ω		40		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 800 \text{ V}, \text{ dI/dt} = -2500 \text{ A/}\mu\text{s}$		490		nC
I _{RRM}	Reverse recovery current			22		Α



Typical Performance Curves

This section shows the typical performance curves of the MSC017SMA120S device.

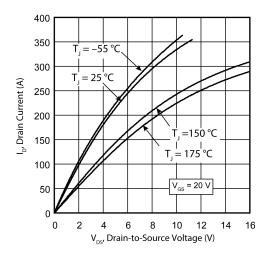


Figure 1 • Drain Current vs. V_{DS}

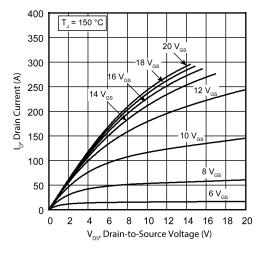


Figure 3 • Drain Current vs. V_{DS}

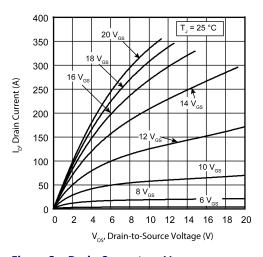


Figure 2 • Drain Current vs. V_{DS}

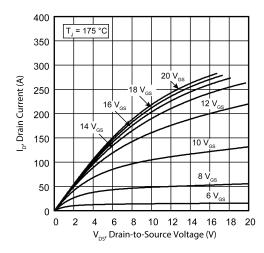


Figure 4 • Drain Current vs. V_{DS}



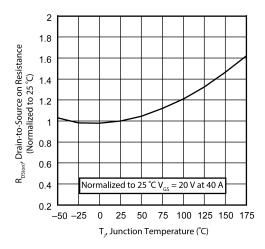


Figure 5 • RDS(on) vs. Junction Temperature

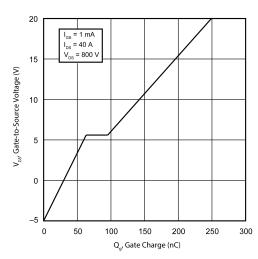


Figure 6 • Gate Charge Characteristics

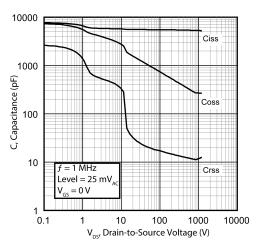


Figure 7 • Capacitance vs. Drain-to-Source Voltage

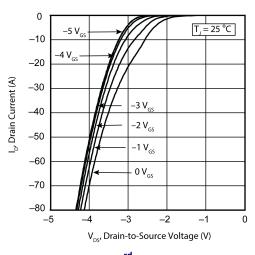


Figure 8 • I_D vs. V_{DS} 3rd Quadrant Conduction

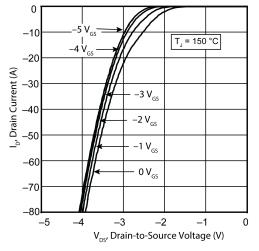


Figure 9 • I_D vs. V_{DS} 3rd Quadrant Conduction

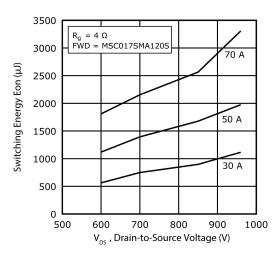


Figure 10 • Switching Energy Eon vs. V_{DS} & I_D



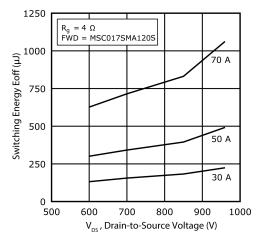


Figure 11 • Switching Energy Eoff vs. V_{DS} & I_D

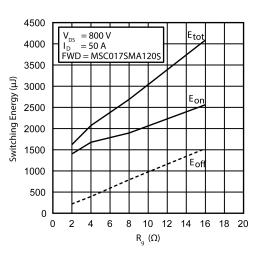


Figure 12 • Switching Energy vs. Rg

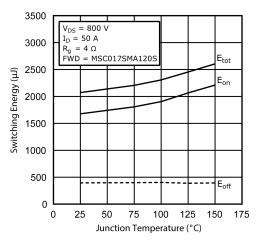


Figure 13 • Switching Energy vs. Temperature

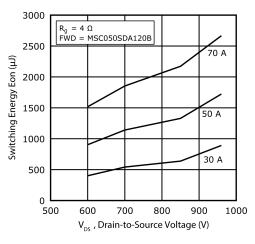


Figure 14 • Switching Energy Eon vs. V_{DS} & I_D

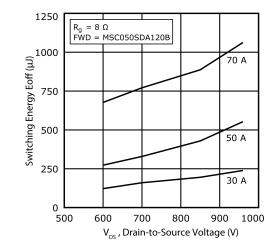


Figure 15 • Switching Energy Eoff vs. V_{DS} & I_D

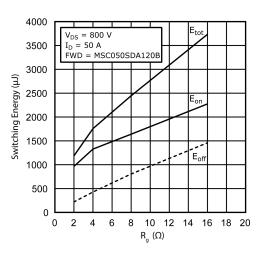
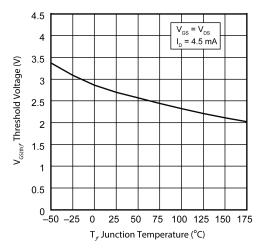


Figure 16 • Switching Energy vs. R_g





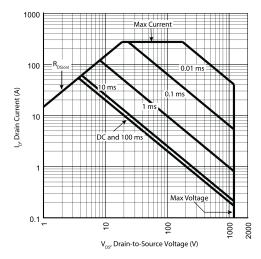


Figure 17 • Threshold Voltage vs. Junction Temp.

Figure 18 • Forward Safe Operating Area

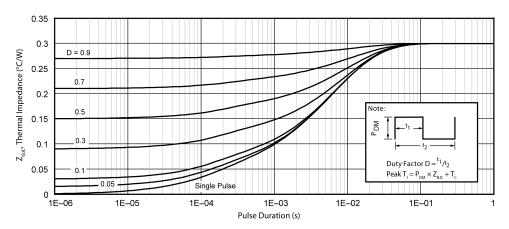


Figure 19 • Maximum Transient Thermal Impedance



Package Specification

This section shows the package specification of the MSC017SMA120S device.

Package Outline Drawing

The following figure illustrates the TO-268 package outline of the MSC017SMA120S device.

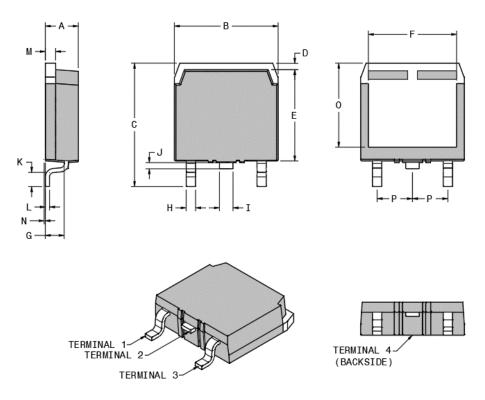


Figure 20 • Package Outline Drawing

The following table shows the TO-268 dimensions and should be used in conjunction with the package outline drawing.

Table 6 • TO-268 Dimensions

Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)
А	4.90	5.10	0.193	0.201
В	15.85	16.20	0.624	0.638
С	18.70	19.10	0.736	0.752
D	1.00	1.25	0.039	0.049
Е	13.80	14.00	0.543	0.551
F	13.30	13.60	0.524	0.535



Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)			
G	2.70	2.90	0.106	0.114			
н	1.15	1.45	0.045	0.057			
I	1.95	2.21	0.077	0.087			
J	0.94	1.40	0.037	0.055			
К	2.40	2.70	0.094	0.106			
L	0.40	0.60	0.016	0.024			
М	1.45	1.60	0.057	0.063			
N	0.00	0.18	0.000	0.007			
0	12.40	12.70	0.488	0.500			
Р	5.45 BSC (nom.)		0.215 BSC (nom.)				
Terminal 1	Gate	Gate					
Terminal 2	Drain						
Terminal 3	Source						
Terminal 4	Drain						





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